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INFORMATION DISCLOSURE			ATTY. DOCKET NO. NIF-107		U.S. APPLICATION NO. Not yet assigned				
CITATION IN AN APPLICATION (PTO-1449)				APPLICANT Kazuyoshi KOIZUMI et al					
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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